

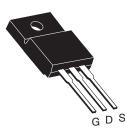
Vishay Siliconix

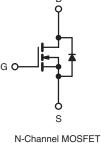


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	250				
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	2.0			
Q _g (Max.) (nC)	8.2				
Q _{gs} (nC)	1.8				
Q _{gd} (nC)	4.5				
Configuration	Single				

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)



- COMPLIANT
- Sink to Lead Creepage Distance = 4.8 mm
- Dynamic dV/dt Rating
- · Low Thermal Resistance
- · Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI614GPbF
	SiHFI614G-E3
SnPb	IRFI614G
	SiHFI614G

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	250	v	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	1-	2.1		
	VGS AL TO V	$T_{C} = 100 ^{\circ}C$	ID	1.3	A	
Pulsed Drain Current ^a			I _{DM}	8.4		
Linear Derating Factor				0.18	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	61	mJ	
Repetitive Avalanche Current ^a			I _{AR}	2.1	А	
Repetitive Avalanche Energy ^a			E _{AR}	2.3	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	23		
Peak Diode Recovery dV/dtc			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6 20 or l	6-32 or M3 screw		10	lbf ⋅ in	
	0-3∠ OF IVI3 SCIEW			1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 22 mH, $R_G = 25 \Omega$, $I_{AS} = 2.1 \text{ A}$ (see fig. 12).

c. $I_{SD} \le 2.7$ A, $dI/dt \le 65$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS							
PARAMETER	SYMBOL	TYP. MAX.			UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 5.5				°C/W		
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,		1			[1		
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static		T				1		1
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	0 V, I _D = 2	50 μΑ	250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	0.39	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{GS}, I_D = 2$	50 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V	$V_{GS} = \pm 20 V$			-	± 100	nA
Zava Cata Valtaga Drain Current	-	$V_{DS} = 250 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	μA
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 200 V	V _{DS} = 200 V, V _{GS} = 0 V, T _J = 125 °C			-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 1.3 A ^b	-	-	2.0	Ω
Forward Transconductance	g _{fs}	V _{DS} =	50 V, I _D =	1.3 A ^b	0.80	-	-	S
Dynamic							•	
Input Capacitance	C _{iss}	N 0.V		-	140	-		
Output Capacitance	C _{oss}		$V_{GS} = 0 V,$ $V_{DS} = 25 V,$		-	42	-	_
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	9.6	-	pF	
Drain to Sink Capacitance	С			<u>.</u>	-	12	-	1
Total Gate Charge	Qg				-	-	8.2	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		$1.7 \text{ A}, \text{ V}_{\text{DS}} = 200 \text{ V},$	-	-	1.8	nC
Gate-Drain Charge	Q _{gd}		see ng	g. 6 and 13 ^b	-	-	4.5	
Turn-On Delay Time	t _{d(on)}				-	7.0	-	
Rise Time	t _r	V _{DD} =	125 V, I _D =	2.7 A,	-	7.6	-	4
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 24 \Omega, R_{D} = 45 \Omega,$ see fig. 10 ^b		_	16	_	ns	
Fall Time	-d(6ii)		see lig. To		-	7.0	-	-
		Between lead,	Potwoon load			-		
Internal Drain Inductance	L _D	6 mm (0.25") fr	rom		-	4.5	-	
Internal Source Inductance	Ls	package and center of die contact		-	7.5	-	nH	
Drain-Source Body Diode Characteristic	s				<u> </u>	I	<u> </u>	1
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.1		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.4	A	
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 2.1 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.0	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = 2.7 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		4 100 A/	-	190	390	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.64	1.3	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D))

Notes

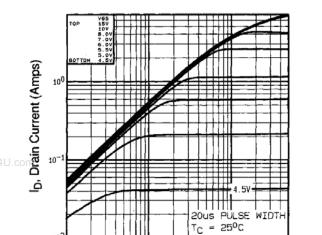
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



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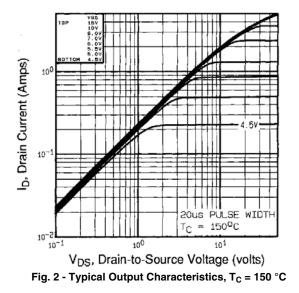


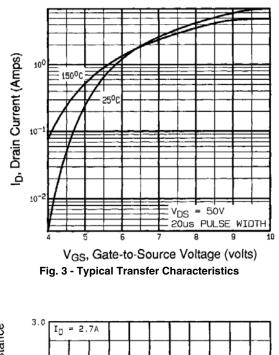
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

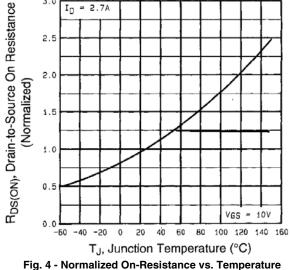


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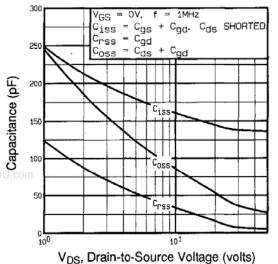




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V_{DS}, Drain-to-Source Voltage (Volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

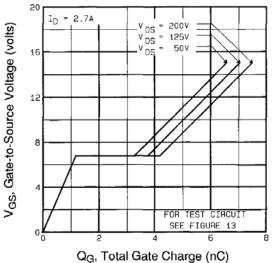


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

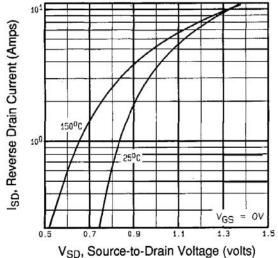
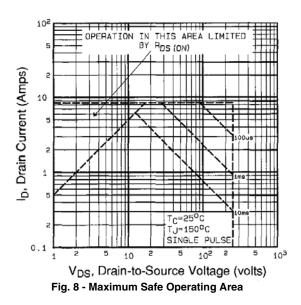


Fig. 7 - Typical Source-Drain Diode Forward Voltage



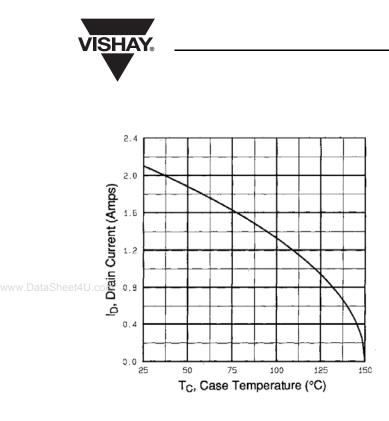


Fig. 9 - Maximum Drain Current vs. Case Temperature

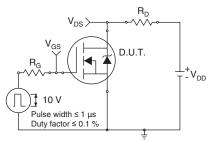


Fig. 10a - Switching Time Test Circuit

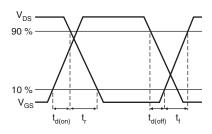
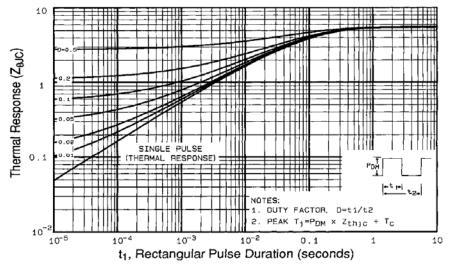


Fig. 10b - Switching Time Waveforms





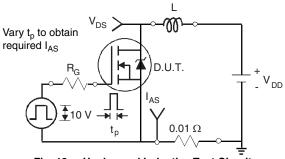


Fig. 12a - Unclamped Inductive Test Circuit

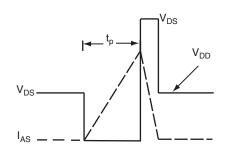


Fig. 12b - Unclamped Inductive Waveforms

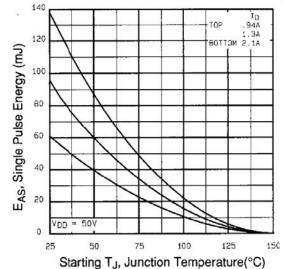
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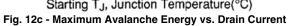
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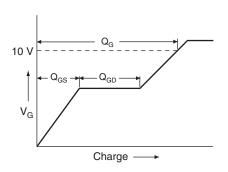
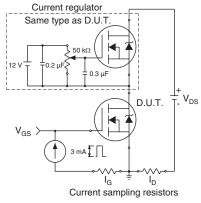
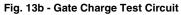
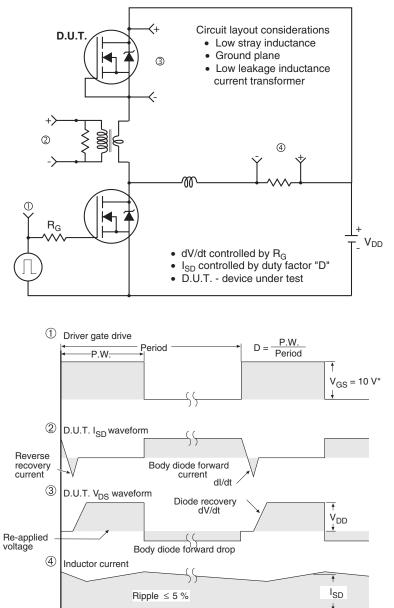


Fig. 13a - Basic Gate Charge Waveform





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Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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